

<b>Notice of References Cited</b>		Application/Control No. 10/825,253	Applicant(s)/Patent Under Reexamination KIM ET AL.	
		Examiner Christine T. Mui	Art Unit 1709	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,366,609	11-1994	White et al.	204/403.04
*	B	US-6,413,213	07-2002	Essenpreis et al.	600/300
*	C	US-2003/0204313	10-2003	Ou-Yang et al.	702/19
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	K	US-			
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**NON-PATENT DOCUMENTS**

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